



Vishay Siliconix

N-Channel 30-V (D-S) MOSFET

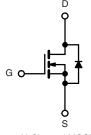
PRODUCT SUMMARY				
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A)		
30	0.011 at V _{GS} = 10 V	14		
	0.0145 at V _{GS} = 4.5 V	12.2		

FEATURES

- Halogen-free
- TrenchFET[®] Power MOSFET
- PWM Optimized
- New Low Thermal Resistance PowerPAK[®]
 Package with Low 1.07 mm Profile
- 100 % R_q Tested
- 100 % UIS Tested

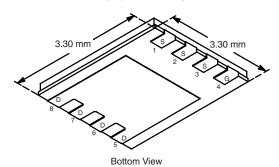
APPLICATIONS

- Adaptor Switch
- · Load Switch



N-Channel MOSFET

PowerPAK 1212-8



Ordering Information: SiS406DN-T1-GE3 (Lead (Pb)-free and Halogen-free)

ABSOLUTE MAXIMUM RATINGS	S T _A = 25 °C, unles	ss otherwise n	oted		
Parameter	Symbol	10 s	Steady State	Unit	
Drain-Source Voltage		V_{DS}	30		V
Gate-Source Voltage		V_{GS}	± 25		
Continuous Drain Current (T _J = 150 °C) ^a	T _A = 25 °C	- I _D	14	9	
	T _A = 70 °C		12.2	7.3	
Pulsed Drain Current		I _{DM}	50		Α
Continuous Source Current (Diode Conduction) ^a		I _S	3.3	1.4	
Single Pulse Avalanche Current	l 0.1 mll	I _{AS}	20		
Avalanche Energy	L = 0.1 mH	E _{AS}	20		mJ
Maximum Power Dissipation ^a	T _A = 25 °C	- P _D	3.7	1.5	W
	T _A = 70 °C		2.3	1.0	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150		°C
Soldering Recommendations (Peak Temperature		260			

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Mariana la satista de Ambienda	t ≤ 10 s	- R _{thJA}	28	34	°C/W	
Maximum Junction-to-Ambient ^a	Steady State		66	81		
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	2.0	2.4		

Notes:

- a. Surface Mounted on 1" x 1" FR4 board.
- b. See Solder Profile (http://www.vishay.com/ppg?73257). The PowerPAK 1212-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- c. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static					l	ı	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			٧	
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	J 050 vA		32		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 6.6			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1.0		3.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current		V _{DS} = 30 V, V _{GS} = 0 V			1	μΑ	
	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C			10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
		V _{GS} = 10 V, I _D = 12 A		0.0088	0.011	Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 10 A		0.0115	0.0145		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 12 A		32		S	
Dynamic ^b				L		I	
Input Capacitance	C _{iss}			1100			
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		215		pF	
Reverse Transfer Capacitance	C _{rss}			95			
· · · · · · · · · · · · · · · · · · ·	Qg	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 16 A		18.2	28	nC	
Total Gate Charge				8.4	13		
Gate-Source Charge	Q_{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 16 \text{ A}$		2.9			
Gate-Drain Charge	Q_{gd}			2.4			
Gate Resistance	R_{g}	f = 1 MHz	0.45	2.2	4.4	Ω	
Turn-On Delay Time	t _{d(on)}			10	20	ns	
Rise Time	t _r	V_{DD} = 15 V, R_L = 15 Ω		10	20		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ 1 A, V_{GEN} = 10 V, R_g = 1 Ω		22	35		
Fall Time	t _f			8	16		
Turn-On Delay Time	t _{d(on)}			20	35		
Rise Time	t _r	V_{DD} = 15 V, R_L = 15 Ω		12	24		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ 1 A, V_{GEN} = 4.5 V, R_g = 1 Ω		25	40		
Fall Time	t _f			12	24		
Drain-Source Body Diode Characteristi	cs						
Continuous Source-Drain Diode Current	I _S	$T_C = 25 ^{\circ}C$			16	A	
Pulse Diode Forward Current ^a	I _{SM}				50		
Body Diode Voltage	V_{SD}	I _S = 2.3 A		0.75	1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			20	40	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	L = 2.2.4 dl/dt = 100.4/ T = 05.90		12	25	nC	
Reverse Recovery Fall Time	t _a	$I_F = 3.2 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		11		T	
Reverse Recovery Rise Time	t _b			9		ns	

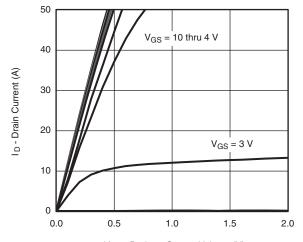
- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



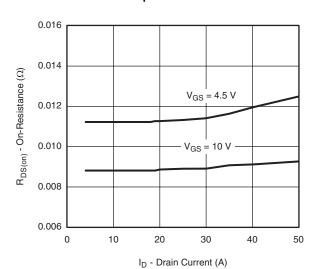
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

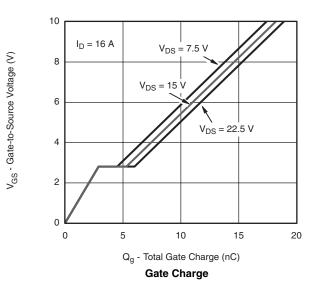


V_{DS} - Drain-to-Source Voltage (V)

Output Characteristics

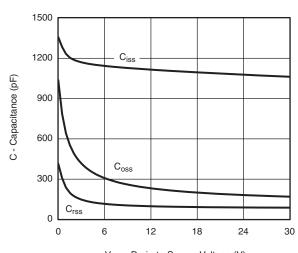


On-Resistance vs. Drain Current and Gate Voltage



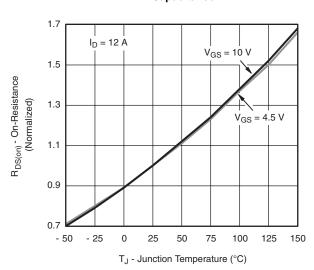
2.0 T_C = - 55 °C 1.5 I_D - Drain Current (A) 1.0 T_C = 25 °C 0.5 T_C = 125 °C 0.0 0.0 0.5 1.0 1.5 2.5 3.0 V_{GS} - Gate-to-Source Voltage (V)

Transfer Characteristics



 $V_{\mbox{\scriptsize DS}}$ - Drain-to-Source Voltage (V)

Capacitance



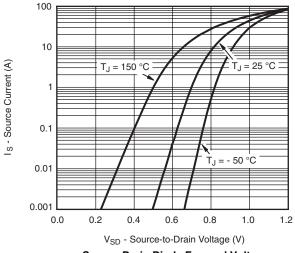
On-Resistance vs. Junction Temperature

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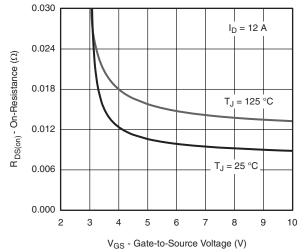
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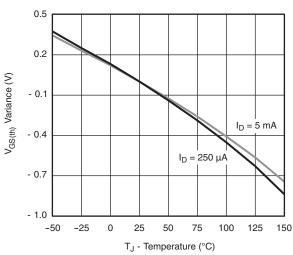
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



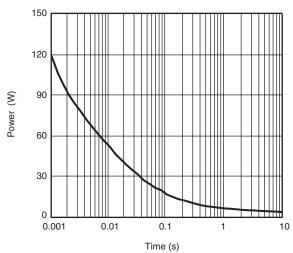
Source-Drain Diode Forward Voltage



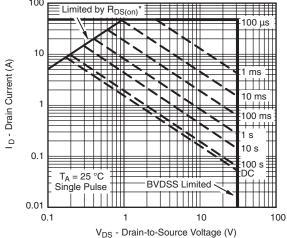
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power, Junction-to-Ambient



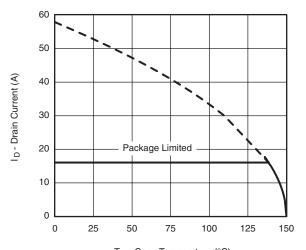
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient



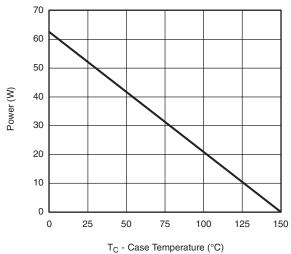
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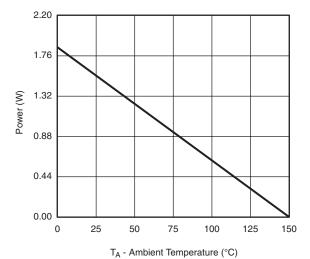
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



T_C - Case Temperature (°C)

Current Derating*





Power, Junction-to-Case

Power, Junction-to-Ambient

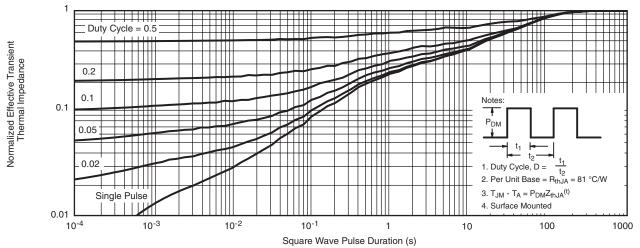
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit

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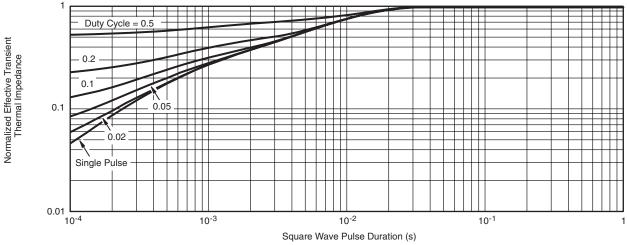
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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